

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S3	1153	(antifuse "anti fuse") same (sram latch)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/05 12:16
S14	133	hur.xa.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:01
S15	6	S14 and battery	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:02
S16	107	S14 and power	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:03
S17	10	S14 and power same detect\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:03
S18	7	("6075404" "6125075" "6256252" "6265932" "6288967" "6493257" "6683805").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/14 15:04
S19	6	("5424994" "5874853" "5936443" "6160431" "6215725" "6768354").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/14 15:11
S20	2121	(non-volatile nonvolatile) near5 (back-up backup "back up")	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/14 15:12
S21	477	(non-volatile nonvolatile) near5 (back-up backup "back up") near5 data	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/14 15:12
S22	29	(non-volatile nonvolatile) near5 (back-up backup "back up") near5 data same eeprom	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/15 08:17
S25	468	(365/96).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/15 09:10

S26	362	(365/185.08).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/15 09:11
S27	2	S26 and protect\$3 near5 high near5 (current voltage)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:02
S28	2	("20050207223").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/05 06:27
S29	13	S25 and protect\$3 near5 high near5 (current voltage)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:28
S30	119	sub near3 quarter near3 micron near3 CMOS	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:38
S31	259	otp and latch and program\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:38
S32	97	otp and latch and program\$4 and complement\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:39
S33	1922	(365/205).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/01 08:51
S34	470	(365/96).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/01 09:52
S36	932	(fuse antifuse) same ("sense amplifier")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 08:54

S37	1085	(365/225.7).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/01 08:59
S39	4	((("20040008539") or ("20030210599")).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/01 11:59
S40	1925	(fuse antifuse) near3 program\$4 near3 circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 09:08
S41	263	(fuse antifuse) near3 program\$4 near3 circuit same latch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 09:08
S42	70	(fuse antifuse) near3 program\$4 near3 circuit same latch same gate	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 09:08
S43	12	("4300212" "4408303" "4527258").PN. OR ("4630238"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 09:22
S44	33	arakawa.in. and fujitsu.as.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 12:08
S45	163	S34 and (latch sram flip-flop)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 10:08
S46	20	("3560764" "3593317" "4177452" "4613958" "4617649" "4660177" "4694425" "4768172" "4779226" "4791603" "4796229" "4845676" "4876466" "4887239").PN. OR ("5063537").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 10:30
S47	5424	(otp prom) same (latch sram)	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 10:31
S48	83	otp same latch	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 10:46

S49	23	(pld pla) same latch same (prom otp)	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 10:47
S50	38	programmable adj logic same latch same (fuse antifuse "anti fuse")	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 10:54
S51	2859	(365/189.05).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/01 10:54
S52	15	S51 and S34	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 10:59
S53	647	complement\$3 same (programmable adj logic)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 10:59
S54	46	complement\$3 same (programmable adj logic) same (fuse antifuse "anti fuse")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 11:14
S55	30	power same down same nonvolatile same sram	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 11:21
S56	62	"one time programmable" same latch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 11:30
S57	4	((("6594192") or ("6584007"))).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/01 11:30
S58	3	("4451903" "5867443" "5870341").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 11:34
S60	4	("4253059" "5239656" "5523915" "5867443").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 11:35

S63	1072	standard near5 cmos near5 technology	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:00
S66	125	sub near3 quarter near3 cmos	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:02
S67	16	S66 and sram	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:03
S68	22	S66 and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:03
S69	19	S66 and "flash memory"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:03
S70	10	S66 and "flash memory" and (sram static near3 memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:06
S73	37	S66 and (dynamic near3 memory dram)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:05
S74	10	S66 and flash near3 memory and (sram static near3 memory) and (dynamic near3 memory dram)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/01 12:06
S75	26	arakawa-hideki.in. and fujitsu.as.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/01 12:08
S79	5	mcclure.in. and "one-time programmable"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 08:27

S80	9	(antifuse anti-fuse) same "one time programmable" same (pair complement\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 08:29
S81	2	(antifuse anti-fuse) same "one time programmable" same (complement\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:06
S82	491	(antifuse anti-fuse) same "one time programmable"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 08:30
S83	61	(antifuse anti-fuse) same "one time programmable" same volatile	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 08:30
S86	516	(antifuse "anti fuse") same latch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:27
S87	48	(antifuse "anti fuse") same latch and prom	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:30
S88	208	(antifuse "anti fuse") same (nonvolatile non-volatile) same (fuse) same (eprom eeprom)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:31
S89	322	(antifuse "anti fuse") same (nonvolatile non-volatile) same (eprom eeprom)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:04
S90	44	(antifuse "anti fuse") same (nonvolatile non-volatile) same (eprom eeprom) same latch\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:37
S91	2	"one-time programmable" same (antifuse anti-fuse) same stor\$3 same (permanent)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 11:33

S92	69	"one-time programmable" same (antifuse anti-fuse) same stor\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:14
S93	8576	(365/185.\$3).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/02 09:46
S94	2859	(365/189.05).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/02 09:46
S96	265	S93 and S94	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:47
S97	204	S96 and latch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 10:20
S98	40	(antifuse "anti fuse") same (nonvolatile non-volatile) same (eprom eeprom) same "one-time programmable"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 09:54
S10 0	336	sram same (nonvolatile non-volatile) same (backup "back up")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 10:50
S10 2	7	sram same (nonvolatile non-volatile) same (backup "back up") same (sleep snooze "power down" powerdown)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 10:51
S10 3	39	("4132904" "4203158" "4274012" "4477825" "4513397" "4527255" "4527259" "4571704" "4571705" "4611309" "4685083").PN. OR ("5097449").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/02 11:06
S10 5	3	"one-time programmable" same (antifuse anti-fuse) same ("serial number" date)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:20

S10 6	297	(antifuse "anti fuse") same (nonvolatile non-volatile) same (eeprom)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:08
S10 7	446	prom same (antifuse anti-fuse)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:15
S10 8	87	prom same (antifuse anti-fuse) same eeprom	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:15
S10 9	333	"one-time programmable" same (antifuse anti-fuse)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 12:21
S11 0	79	"one-time programmable" same (antifuse anti-fuse) same (nonvolatile non-volatile)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 13:34
S11 1	46	"one-time programmable" and (antifuse anti-fuse).ti.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 13:35
S11 2	18	"one-time programmable" and (antifuse anti-fuse).ti. and prom	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 13:57
S11 3	32	(antifuse anti-fuse) same block\$3 near3 transistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/02 13:58
S11 6	32	(antifuse "anti fuse").ti. and "one time programmable" same fuse same (antifuse "anti fuse")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/05 07:09
S11 7	49	volatile same nonvolatile same (antifuse "anti fuse")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/05 08:10
S11 8	5	("6542000").URPN.	USPAT	OR	ON	2005/12/05 08:22

S12 0	22	nonvolatile adj latch	USPAT	OR	ON	2005/12/05 08:31
S12 2	2	nonvolatile adj latch and (antifuse "anti fuse")	USPAT	OR	ON	2005/12/05 09:08
S12 3	1316	(transistor mosfet fet) same (antifuse "anti fuse")	USPAT	OR	ON	2005/12/05 09:10
S12 4	45	(transistor mosfet fet) same (antifuse "anti fuse") same thick\$4 same oxide same gate	USPAT	OR	ON	2005/12/05 09:19
S12 5	87	(antifuse "anti fuse") adj (transistor mosfet fet)	USPAT	OR	ON	2005/12/05 09:19
S12 6	11	(antifuse "anti fuse") adj (transistor mosfet fet) same thick\$4	USPAT	OR	ON	2005/12/05 09:34
S12 7	2	(transistor mosfet fet) adj (antifuse "anti fuse") same thick\$4	USPAT	OR	ON	2005/12/05 10:43
S12 9	4	("5278784" "5886392" "6044012" "6266269").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/05 10:36
S13 0	5	("6525955").URPN.	USPAT	OR	ON	2005/12/05 10:37
S13 1	45	latch near (antifuse "anti fuse")	USPAT	OR	ON	2005/12/05 11:00
S13 5	355	fpga and (antifuse "anti fuse") and latch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/05 11:09
S13 6	251	fpga and (antifuse "anti fuse") and latch and fuse	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/05 11:05
S13 7	23	fpga same (antifuse "anti fuse") same latch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/05 11:09
S13 9	93	("4308627" "4460982" "4571704" "4858185" "5031142" "5047664" "5097449" "5144159" "5214316" "5249158" "5280447" "5282990" "5311470" "5369754" "5377199" "5378936" "5402370" "5463757" "5509134" "5526364" "5546561" "5615159" "5619453" "5627784" "5661690" "5675540" "5677885").PN. OR ("6141247").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/07 08:15